

Search Notes

Application/Control No.

10/816,230

Examiner

Christopher L. Chin

Applicant(s)/Patent under
Reexamination

BLATT ET AL.

Art Unit

1641

SEARCHED

Class	Subclass	Date	Examiner
updated	search	12/26/2007	CC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR